

FEATURES

All Grades 14-Bit Monotonic Over the Full Temperature Range
 Low Cost 14-Bit Upgrade for 12-Bit Systems
 14-Bit Parallel Load with Double Buffered Inputs
 Small 24-Pin, 0.3" DIP and SOIC
 Low Output Leakage (<20 nA) Over the Full Temperature Range

APPLICATIONS

Microprocessor Based Control Systems
 Digital Audio
 Precision Servo Control
 Control and Measurement in High Temperature Environments

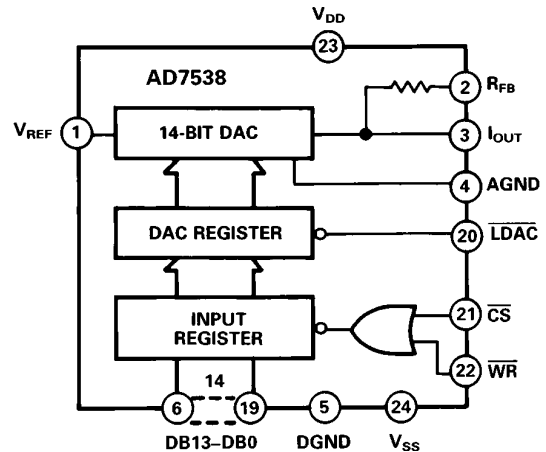
GENERAL DESCRIPTION

The AD7538 is a 14-bit monolithic CMOS D/A converter which uses laser trimmed thin-film resistors to achieve excellent linearity.

The DAC is loaded by a single 14-bit wide word using standard Chip Select and Memory Write Logic. Double buffering, which is optional using $\overline{\text{LDAC}}$, allows simultaneous update in a system containing multiple AD7538s.

A novel low leakage configuration (U.S. Patent No. 4,590,456) enables the AD7538 to exhibit excellent output leakage current characteristics over the specified temperature range.

The AD7538 is manufactured using the Linear Compatible CMOS (LC²MOS) process. It is speed compatible with most microprocessors and accepts TTL or CMOS logic level inputs.

FUNCTIONAL BLOCK DIAGRAM

PRODUCT HIGHLIGHTS

- Guaranteed Monotonicity**
 The AD7538 is guaranteed monotonic to 14-bits over the full temperature range for all grades.
- Low Cost**
 The AD7538, with its 14-bit dynamic range, affords a low cost solution for 12-bit system upgrades.
- Small Package Size**
 The AD7538 is packaged in a small 24-pin, 0.3" DIP and a 24-pin SOIC.
- Low Output Leakage**
 By tying V_{SS} (Pin 24) to a negative voltage, it is possible to achieve a low output leakage current at high temperatures.
- Wide Power Supply Tolerance**
 The device operates on a +12 V to +15 V V_{DD} , with a $\pm 5\%$ tolerance on this nominal figure. All specifications are guaranteed over this range.

REV. A

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AD7538—SPECIFICATIONS¹ ($V_{DD} = +11.4\text{ V to }+15.75\text{ V}^2$, $V_{REF} = +10\text{ V}$; $V_{PIN3} = V_{PIN4} = 0\text{ V}$, $V_{SS} = -300\text{ mV}$. All specifications T_{MIN} to T_{MAX} unless otherwise noted.)

Parameter	J, K Versions	A, B Versions	S Version	T Version	Units	Test Conditions/Comments	
ACCURACY							
Resolution	14	14	14	14	Bits	All Grades Guaranteed Monotonic Over Temperature. Measured Using Internal R_{FB} DAC Registers Loaded with All 1s.	
Relative Accuracy	± 2	± 1	± 2	± 1	LSB max		
Differential Nonlinearity	± 1	± 1	± 1	± 1	LSB max		
Full-Scale Error							
+25°C	± 4	± 4	± 4	± 4	LSB max		
T_{MIN} to T_{MAX}	± 8	± 5	± 10	± 6	LSB max		
Gain Temperature Coefficient ³ ; $\Delta\text{Gain}/\Delta\text{Temperature}$	± 2	± 2	± 2	± 2	ppm/°C typ		
Output Leakage Current I_{OUT} (Pin 3)							
+25°C	± 5	± 5	± 5	± 5	nA max		All Digital Inputs 0 V $V_{SS} = -300\text{ mV}$ $V_{SS} = 0\text{ V}$
T_{MIN} to T_{MAX}	± 10	± 10	± 20	± 20	nA max		
T_{MIN} to T_{MAX}	± 25	± 25	± 150	± 150	nA max		
REFERENCE INPUT							
Input Resistance, Pin 1	3.5 10	3.5 10	3.5 10	3.5 10	k Ω min k Ω max	Typical Input Resistance = 6 k Ω	
DIGITAL INPUTS							
V_{IH} (Input High Voltage)	2.4	2.4	2.4	2.4	V min	$V_{IN} = 0\text{ V or }V_{DD}$	
V_{IL} (Input Low Voltage)	0.8	0.8	0.8	0.8	V max		
I_{IN} (Input Current)							
+25°C	± 1	± 1	± 1	± 1	$\mu\text{A max}$		
T_{MIN} to T_{MAX}	± 10	± 10	± 10	± 10	$\mu\text{A max}$		
C_{IN} (Input Capacitance) ³	7	7	7	7	pF max		
POWER SUPPLY							
V_{DD} Range	11.4/15.75	11.4/15.75	11.4/15.75	11.4/15.75	V min/V max	Specification Guaranteed Over This Range All Digital Inputs V_{IL} or V_{IH} All Digital Inputs 0 V or V_{DD}	
V_{SS} Range	-200/-500	-200/-500	-200/-500	-200/-500	mV min/mV max		
I_{DD}	4	4	4	4	mA max		
	500	500	500	500	$\mu\text{A max}$		

These characteristics are included for Design Guidance only and are not subject to test. ($V_{DD} = +11.4\text{ V to }+15.75\text{ V}$, $V_{REF} = +10\text{ V}$, $V_{PIN3} = V_{PIN4} = 0\text{ V}$, $V_{SS} = 0\text{ V or }-300\text{ mV}$, Output Amplifier is AD711 except where noted.)

AC PERFORMANCE CHARACTERISTICS

Parameter	$T_A = +25^\circ\text{C}$ $T_A = T_{MIN}, T_{MAX}$		Units	Test Conditions/Comments
Output Current Settling Time	1.5		$\mu\text{s max}$	To 0.003% of Full-Scale Range. I_{OUT} Load = 100 Ω , $C_{EXT} = 13\text{ pF}$. DAC Register Alternately Loaded with All 1s and All 0s. Typical Value of Settling Time Is 0.8 μs .
Digital to Analog Glitch Impulse	20		nV-sec typ	Measured with $V_{REF} = 0\text{ V}$. I_{OUT} Load = 100 Ω , $C_{EXT} = 13\text{ pF}$. DAC Register Alternately Loaded with All 1s and All 0s.
Multiplying Feedthrough Error	3	5	mV p-p typ	$V_{REF} = \pm 10\text{ V}$, 10 kHz Sine Wave DAC Register Loaded with All 0s.
Power Supply Rejection $\Delta\text{Gain}/\Delta V_{DD}$	± 0.01	± 0.02	% per % max	$\Delta V_{DD} = \pm 5\%$
Output Capacitance C_{OUT} (Pin 3)	260	260	pF max	DAC Register Loaded with All 1s
C_{OUT} (Pin 3)	130	130	pF max	DAC Register Loaded with All 0s
Output Noise Voltage Density (10 Hz–100 kHz)	15		nV $\sqrt{\text{Hz}}$ typ	Measured Between R_{FB} and I_{OUT}

NOTES

Temperature range as follows: J, K Versions: 0°C to +70°C
A, B Versions: -25°C to +85°C
S, T Versions: -55°C to +125°C

²Specifications are guaranteed for a V_{DD} of +11.4 V to +15.75 V. At $V_{DD} = 5\text{ V}$, the device is fully functional with degraded specifications.

³Sample tested to ensure compliance.

Specifications subject to change without notice.

TIMING CHARACTERISTICS¹ ($V_{DD} = +11.4\text{ V to }+15.75\text{ V}$, $V_{REF} = +10\text{ V}$, $V_{PIN3} = V_{PIN4} = 0\text{ V}$, $V_{SS} = 0\text{ V or }-300\text{ mV}$. All specifications T_{MIN} to T_{MAX} unless otherwise noted. See Figure 1 for Timing Diagram.)

Parameter	Limit at $T_A = +25^\circ\text{C}$	Limit at $T_A = 0^\circ\text{C to }+70^\circ\text{C}$ $T_A = -25^\circ\text{C to }+85^\circ\text{C}$	Limit at $T_A = -55^\circ\text{C to }+125^\circ\text{C}$	Units	Test Conditions/Comments
t_1	0	0	0	ns min	$\overline{\text{CS}}$ to $\overline{\text{WR}}$ Setup Time
t_2	0	0	0	ns min	$\overline{\text{CS}}$ to $\overline{\text{WR}}$ Hold Time
t_3	170	200	240	ns min	LDAC Pulse Width
t_4	170	200	240	ns min	Write Pulse Width
t_5	140	160	180	ns min	Data Setup Time
t_6	20	20	30	ns min	Data Hold Time

NOTES

¹Temperature range as follows: J, K Versions: $0^\circ\text{C to }+70^\circ\text{C}$
 A, B Versions: $-25^\circ\text{C to }+85^\circ\text{C}$
 S, T Versions: $-55^\circ\text{C to }+125^\circ\text{C}$

Specifications subject to change without notice.

ABSOLUTE MAXIMUM RATINGS*

($T_A = +25^\circ\text{C}$ unless otherwise stated)

- V_{DD} (Pin 23) to DGND $-0.3\text{ V, }+17\text{ V}$
- V_{SS} (Pin 24) to AGND $-15\text{ V, }+0.3\text{ V}$
- V_{REF} (Pin 1) to AGND $\pm 25\text{ V}$
- V_{RFB} (Pin 2) to AGND $\pm 25\text{ V}$
- Digital Input Voltage (Pins 6–22)
 to DGND $-0.3\text{ V, }V_{DD} + 0.3\text{ V}$
- V_{PIN3} to DGND $-0.3\text{ V, }V_{DD} + 0.3\text{ V}$
- AGND to DGND $-0.3\text{ V, }V_{DD} + 0.3\text{ V}$
- Power Dissipation (Any Package)
 To $+75^\circ\text{C}$ 1000 mW
 Derates Above $+75^\circ\text{C}$ $10\text{ mW}/^\circ\text{C}$

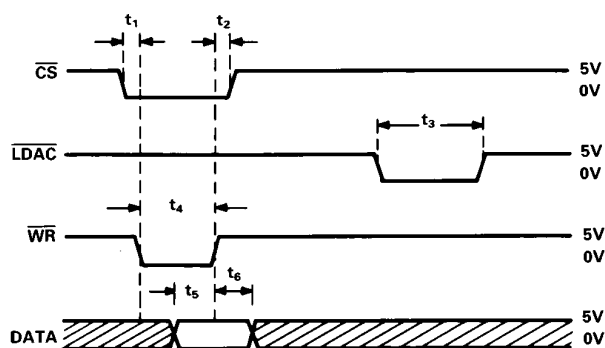
Operating Temperature Range

- Commercial (J, K Versions) $0^\circ\text{C to }+70^\circ\text{C}$
- Industrial (A, B Versions) $-25^\circ\text{C to }+85^\circ\text{C}$
- Extended (S, T Versions) $-55^\circ\text{C to }+125^\circ\text{C}$
- Storage Temperature $-65^\circ\text{C to }+150^\circ\text{C}$
- Lead Temperature (Soldering, 10 sec) $+300^\circ\text{C}$

*Stresses above those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although the AD7538 features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.

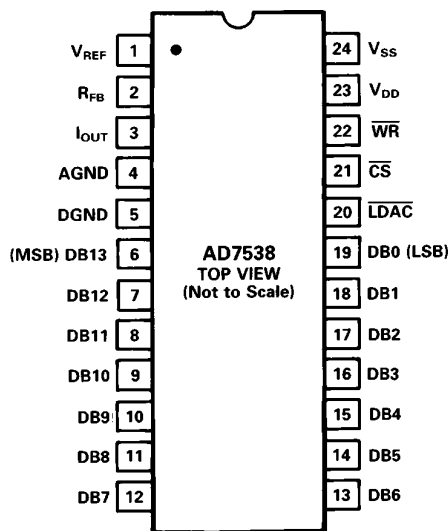


NOTES

1. ALL INPUT SIGNAL RISE AND FALL TIMES MEASURES FROM 10% TO 90% OF $+5\text{ V}$. $t_r = t_f = 20\text{ ns}$.
2. TIMING MEASUREMENT REFERENCE LEVEL IS $\frac{V_{IH} + V_{IL}}{2}$
3. IF $\overline{\text{LDAC}}$ IS ACTIVATED PRIOR TO THE RISING EDGE OF $\overline{\text{WR}}$, THEN IT MUST STAY LOW FOR t_3 OR LONGER AFTER $\overline{\text{WR}}$ GOES HIGH.

Figure 1. Timing Diagram

PIN CONFIGURATION
DIP, SOIC



AD7538

TERMINOLOGY

RELATIVE ACCURACY

Relative accuracy or endpoint nonlinearity is a measure of the maximum deviation from a straight line passing through the endpoints of the DAC transfer function. It is measured after adjusting for zero error and full-scale error and is normally expressed in Least Significant Bits or as a percentage of full-scale reading.

DIFFERENTIAL NONLINEARITY

Differential nonlinearity is the difference between the measured change and the ideal 1 LSB change between any two adjacent codes. A specified differential nonlinearity of ± 1 LSB max over the operating temperature range ensures monotonicity.

GAIN ERROR

Gain error is a measure of the output error between an ideal DAC and the actual device output. It is measured with all 1s in the DAC after offset error has been adjusted out and is expressed

in Least Significant Bits. Gain error is adjustable to zero with an external potentiometer.

DIGITAL-TO-ANALOG GLITCH IMPULSE

The amount of charge injected from the digital inputs to the analog output when the inputs change state is called Digital-to-Analog Glitch Impulse. This is normally specified as the area of the glitch in either pA-secs or nV-secs depending upon whether the glitch is measured as a current or voltage. It is measured with $V_{REF} = AGND$.

OUTPUT CAPACITANCE

This is the capacitance from I_{OUT} to AGND.

OUTPUT LEAKAGE CURRENT

Output Leakage Current is current which appears at I_{OUT} with the DAC register loaded to all 0s.

MULTIPLYING FEEDTHROUGH ERROR

This is the ac error due to capacitive feedthrough from V_{REF} terminal to I_{OUT} with DAC register loaded to all zeros.

ORDERING GUIDE

Model	Temperature Range	Relative Accuracy	Full-Scale Error	Package Option*
AD7538JN	0°C to +70°C	± 2 LSB	± 8 LSB	N-24
AD7538KN	0°C to +70°C	± 1 LSB	± 4 LSB	N-24
AD7538JR	0°C to +70°C	± 2 LSB	± 8 LSB	R-24
AD7538KR	0°C to +70°C	± 1 LSB	± 4 LSB	R-24
AD7538AQ	-25°C to +85°C	± 2 LSB	± 8 LSB	Q-24
AD7538BQ	-25°C to +85°C	± 1 LSB	± 4 LSB	Q-24
AD7538SQ	-55°C to +125°C	± 2 LSB	± 8 LSB	Q-24
AD7538TQ	-55°C to +125°C	± 1 LSB	± 4 LSB	Q-24

*N = Plastic DIP; Q = Cerdip; R = SOIC.

PIN FUNCTION DESCRIPTION

Pin	Mnemonic	Description																								
1	V_{REF}	Voltage Reference.																								
2	R_{FB}	Feedback Resistor. Used to close the loop around an external op amp.																								
3	I_{OUT}	Current Output Terminal.																								
4	AGND	Analog Ground																								
5	DGND	Digital Ground																								
6-19	DB13-DB0	Data Inputs. Bit 13 (MSB) to Bit 0 (LSB).																								
20	\overline{LDAC}	Chip Select Input. Active LOW.																								
21	\overline{CS}	Asynchronous Load DAC Input. Active LOW.																								
22	\overline{WR}	Write Input. Active LOW.																								
<table border="1"> <thead> <tr> <th>\overline{CS}</th> <th>\overline{LDAC}</th> <th>\overline{WR}</th> <th>OPERATION</th> </tr> </thead> <tbody> <tr> <td>0</td> <td>1</td> <td>0</td> <td>Load Input Register.</td> </tr> <tr> <td>1</td> <td>0</td> <td>X</td> <td>Load DAC Register from Input Register.</td> </tr> <tr> <td>0</td> <td>0</td> <td>0</td> <td>Input and DAC Registers are Transparent.</td> </tr> <tr> <td>1</td> <td>1</td> <td>X</td> <td>No Operation.</td> </tr> <tr> <td>X</td> <td>1</td> <td>1</td> <td>No Operation.</td> </tr> </tbody> </table>			\overline{CS}	\overline{LDAC}	\overline{WR}	OPERATION	0	1	0	Load Input Register.	1	0	X	Load DAC Register from Input Register.	0	0	0	Input and DAC Registers are Transparent.	1	1	X	No Operation.	X	1	1	No Operation.
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1	1	X	No Operation.																							
X	1	1	No Operation.																							
NOTE: X Don't Care.																										
23	V_{DD}	+12 V to +15 V supply input.																								
24	V_{SS}	Bias pin for High Temperature Low Leakage configuration. To implement low leakage system, the pin should be at a negative voltage. See Figures 4 and 5 for recommended circuitry.																								

D/A SECTION

Figure 2 shows a simplified circuit diagram for the AD7538 D/A section. The three MSBs of the 14-bit Data Word are decoded to drive the seven switches A-G. The 11 LSBs of the Data Word consist of an R-2R ladder operated in a current steering configuration.

The R-2R ladder current is 1/8 of the total reference input current. 7/8 I flows in the parallel ladder structure. Switches A-G steer equally weighted currents between I_{OUT} and AGND.

Since the input resistance at V_{REF} is constant, it may be driven by a voltage source or a current source of positive or negative polarity.

CIRCUIT INFORMATION

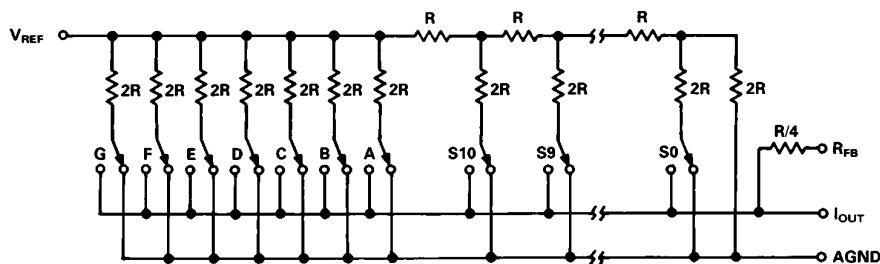


Figure 2. Simplified Circuit Diagram for the AD7538 D/A Section

EQUIVALENT CIRCUIT ANALYSIS

Figure 3 shows an equivalent circuit for the analog section of the AD7538 D/A converter. The current source I_{LEAKAGE} is composed of surface and junction leakages. The resistor R_O denotes the equivalent output resistance of the DAC which varies with input code. C_{OUT} is the capacitance due to the current steering switches and varies from about 90 pF to 180 pF (typical values) depending upon the digital input. g(V_{REF}, N) is the Thevenin equivalent voltage generator due to the reference input voltage, V_{REF}, and the transfer function of the DAC ladder, N.

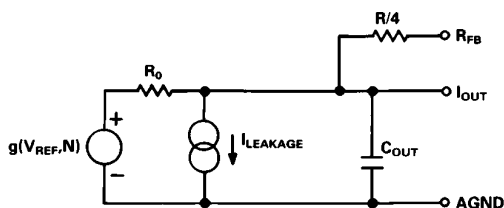


Figure 3. AD7538 Equivalent Analog Output Circuit

DIGITAL SECTION

The digital inputs are designed to be both TTL and 5 V CMOS compatible. All logic inputs are static protected MOS gates with typical input currents of less than 1 nA. To minimize power supply currents, it is recommended that the digital input voltages be driven as close as possible to 0 V and 5 V logic levels.

UNIPOLAR BINARY OPERATION (2-QUADRANT MULTIPLICATION)

Figure 4 shows the circuit diagram for unipolar binary operation. With an ac input, the circuit performs 2 quadrant multiplication. The code table for Figure 4 is given in Table I.

Capacitor C1 provides phase compensation and helps prevent overshoot and ringing when high-speed op amps are used.

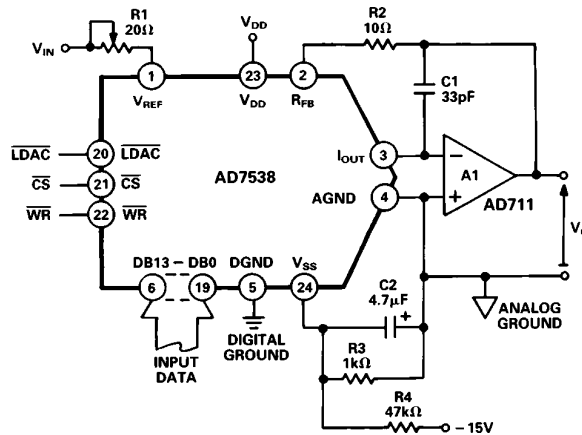


Figure 4. Unipolar Binary Operation

Table I. Unipolar Binary Code Table for AD7538

Binary Number In DAC Register	Analog Output, V _{OUT}
MSB LSB	
11 1111 1111 1111	$-V_{IN} \left(\frac{16383}{16384} \right)$
10 0000 0000 0000	$-V_{IN} \left(\frac{8192}{16384} \right) = -1/2 V_{IN}$
00 0000 0000 0001	$-V_{IN} \left(\frac{1}{16384} \right)$
00 0000 0000 0000	0 V

AD7538

For zero offset adjustment, the DAC register is loaded with all 0s and amplifier offset (V_{OS}) adjusted so that V_{OUT} is 0 V. Adjusting V_{OUT} to 0 V is not necessary in many applications, but it is recommended that V_{OS} be no greater than $(25 \times 10^{-6}) (V_{REF})$ to maintain specified DAC accuracy (see Applications Hints).

Full-scale trimming is accomplished by loading the DAC register with all 1s and adjusting R1 so that $V_{OUTA} = -V_{IN}$ (16383/16384). For high temperature operation, resistors and potentiometers should have a low Temperature Coefficient. In many applications, because of the excellent Gain T.C. and Gain Error specifications of the AD7538, Gain Error trimming is not necessary. In fixed reference applications, full scale can also be adjusted by omitting R1 and R2 and trimming the reference voltage magnitude.

BIPOLAR OPERATION (4-QUADRANT MULTIPLICATION)

The recommended circuit diagram for bipolar operation is shown in Figure 5. Offset binary coding is used. The code table for Figure 5 is given in Table II.

With the DAC loaded to 10 0000 0000 0000, adjust R1 for $V_O = 0$ V. Alternatively, one can omit R1 and R2 and adjust the ratio of R5 and R6 for $V_O = 0$ V. Full-scale trimming can be accomplished by adjusting the amplitude of V_{IN} or by varying the value of R7.

The values given for R1, R2 are the minimum necessary to calibrate the system for resistors, R5, R6, R7 ratio matched to 0.1%. System linearity error is independent of resistor ratio matching and is affected by DAC linearity error only.

When operating over a wide temperature range, it is important that the resistors be of the same type so that their temperature coefficients match.

For further information see "CMOS DAC Application Guide", 3rd Edition, Publication Number G872b-8-1/89 available from Analog Devices.

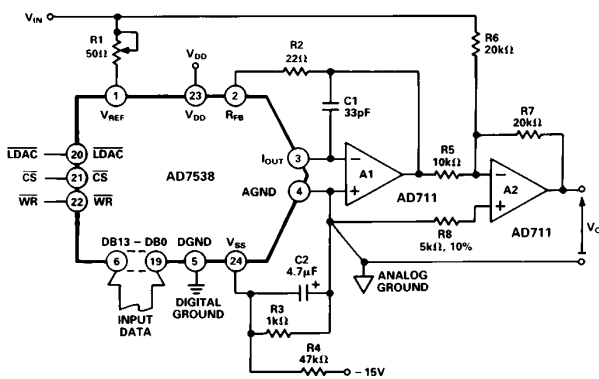


Figure 5. Bipolar Operation

LOW LEAKAGE CONFIGURATION

For CMOS Multiplying D/A converters, as the device is operated at higher temperatures, the output leakage current increases. For a 14-bit resolution system, this can be a significant source of error. The AD7538 features a leakage reduction configuration (U.S. Patent No. 4,590,456) to keep the leakage current low over an extended temperature range. One may operate the device with or without this configuration. If V_{SS} (Pin 24) is tied to AGND then the DAC will exhibit normal output leakage current at high temperatures. To use the low leakage facility,

Table II. Bipolar Code Table for Offset Binary Circuit of Figure 5.

Binary Number In DAC Register	Analog Output V_{OUT}
MSB LSB	
11 1111 1111 1111	$+V_{IN} \left(\frac{8191}{8192} \right)$
10 0000 0000 0001	$+V_{IN} \left(\frac{1}{8192} \right)$
10 0000 0000 0000	0 V
01 1111 1111 1111	$-V_{IN} \left(\frac{1}{8192} \right)$
00 0000 0000 0000	$-V_{IN} \left(\frac{8191}{8192} \right)$

V_{SS} should be tied to a voltage of approximately -0.3 V as in Figures 4 and 5. A simple resistor divider (R3, R4) produces approximately -300 mV from -15 V. The capacitor C2 in parallel with R3 is an integral part of the low leakage configuration and must be $4.7 \mu\text{F}$ or greater. Figure 6 is a plot of leakage current versus temperature for both conditions. It clearly shows the improvement gained by using the low leakage configuration.

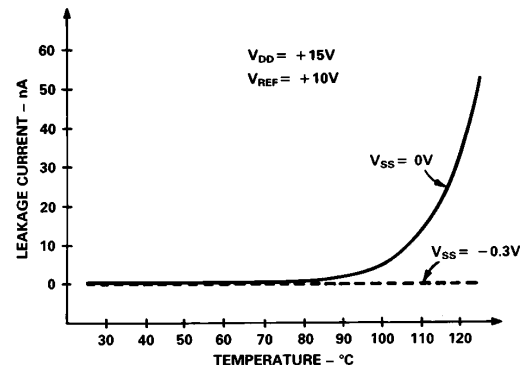


Figure 6. Graph of Typical Leakage Current vs. Temperature for AD7538

PROGRAMMABLE GAIN AMPLIFIER

The circuit shown in Figure 7 provides a programmable gain amplifier (PGA). In it the DAC behaves as a programmable resistance and thus allows the circuit gain to be digitally controlled.

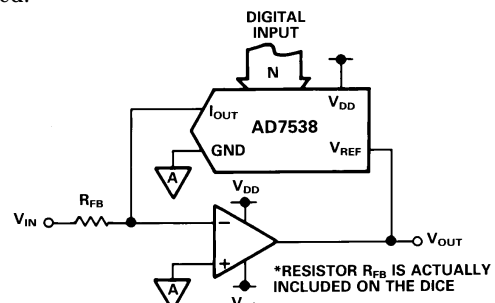


Figure 7. Programmable Gain Amplifier (PGA)

The transfer function of Figure 7 is:

$$Gain = \frac{V_{OUT}}{V_{IN}} = -\frac{R_{EQ}}{R_{FB}} \quad (1)$$

R_{EQ} is the equivalent transfer impedance of the DAC from the V_{REF} pin to the I_{OUT} pin and can be expressed as

$$R_{EQ} = \frac{2^n R_{IN}}{N} \quad (2)$$

Where: n is the resolution of the DAC

N is the DAC input code in decimal

R_{IN} is the constant input impedance of the DAC ($R_{IN} = R_{LAD}$)

Substituting this expression into Equation 1 and assuming zero gain error for the DAC ($R_{IN} = R_{FB}$) the transfer function simplifies to

$$\frac{V_{OUT}}{V_{IN}} = -\frac{2^n}{N} \quad (3)$$

The ratio $N/2^n$ is commonly represented by the term D and, as such, is the fractional representation of the digital input word.

$$\frac{V_{OUT}}{V_{IN}} = -\frac{2^n}{N} = -\frac{1}{D} \quad (4)$$

Equation 4 indicates that the gain of the circuit can be varied from 16,384 down to unity (actually 16,384/16,383) in 16,383 steps. The all 0s code is never applied. This avoids an open-loop condition thereby saturating the amplifier. With the all 0s code excluded there remains $2^n - 1$ possible input codes allowing a choice of $2^n - 1$ output levels. In dB terms the dynamic range is

$$20 \log_{10} \frac{V_{OUT}}{V_{IN}} = 20 \log_{10} (2^n - 1) = 84 \text{ dB}$$

APPLICATION HINTS

Output Offset: CMOS D/A converters in circuits such as Figures 4 and 5 exhibit a code dependent output resistance which in turn can cause a code dependent error voltage at the output of the amplifier. The maximum amplitude of this error, which adds to the D/A converter nonlinearity, depends on V_{OS} , where V_{OS} is the amplifier input offset voltage. To maintain specified accuracy with V_{REF} at 10 V, it is recommended that V_{OS} be no greater than 0.25 mV, or $(25 \times 10^{-6}) (V_{REF})$, over the temperature range of operation. The AD711 is a suitable op amp. The op amp has a wide bandwidth and high slew rate and is recommended for ac and other applications requiring fast settling.

General Ground Management: Since the AD7538 is specified for high accuracy, it is important to use a proper grounding technique. AC or transient voltages between AGND and DGND can cause noise injection into the analog output. The simplest method of ensuring that voltages at AGND and DGND are equal is to tie AGND and DGND together at the AD7538. In more complex systems where the AGND and DGND intertie is on the backplane, it is recommended that two diodes be connected in inverse parallel between the AD7538 AGND and DGND pins (1N914 or equivalent).

MICROPROCESSOR INTERFACING

The AD7538 is designed for easy interfacing to 16-bit microprocessors and can be treated as a memory mapped peripheral. This reduces the amount of external logic needed for interfacing to a minimal.

AD7538-8086 INTERFACE

Figure 8 shows the 8086 processor interface to a single device. In this setup the double buffering feature (using \overline{LDAC}) of the DAC is not used. The 14-bit word is written to the DAC in one MOV instruction and the analog output responds immediately.

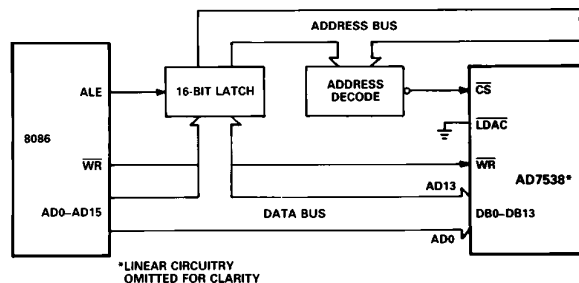


Figure 8. AD7538-8086 Interface Circuit

In a multiple DAC system the double buffering of the AD7538 allows the user to simultaneously update all DACs. In Figure 9, a 14-bit word is loaded to the Input Registers of each of the DACs in sequence. Then, with one instruction to the appropriate address, CS4 (i.e., \overline{LDAC}) is brought low, updating all the DACs simultaneously.

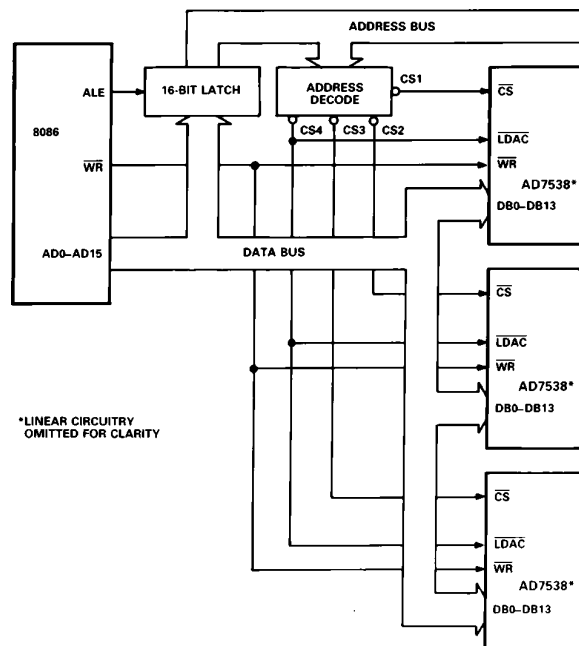


Figure 9. AD7538-8086 Interface: Multiple DAC System

AD7538

AD7538-MC68000 INTERFACE

Figure 10 shows the MC68000 processor interface to a single device. In this setup the double buffering feature of the DAC is not used and the appropriate data is written into the DAC in one MOVE instruction.

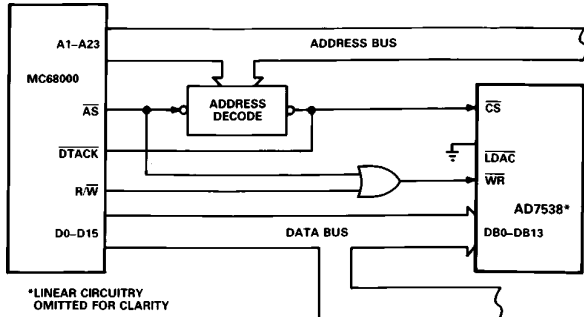


Figure 10. AD7538-MC68000 Interface

DIGITAL FEEDTHROUGH

The digital inputs to the AD7538 are directly connected to the

microprocessor bus in the preceding interface configurations. These inputs will be constantly changing even when the device is not selected. The high frequency logic activity on the bus can feed through the DAC package capacitance to show up as noise on the analog output. To minimize this Digital Feedthrough isolate the DAC from the noise source. Figure 11 shows an interface circuit which uses this technique. All data inputs are latched from the bus by the CS signal. One may also use other means, such as peripheral interface devices, to reduce the Digital Feedthrough.

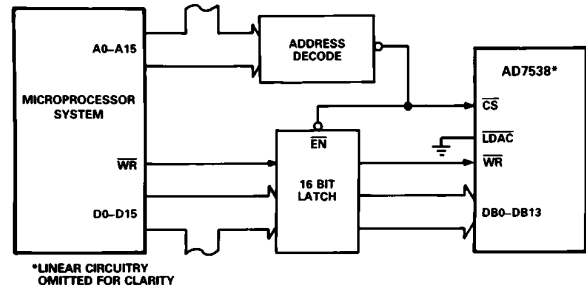
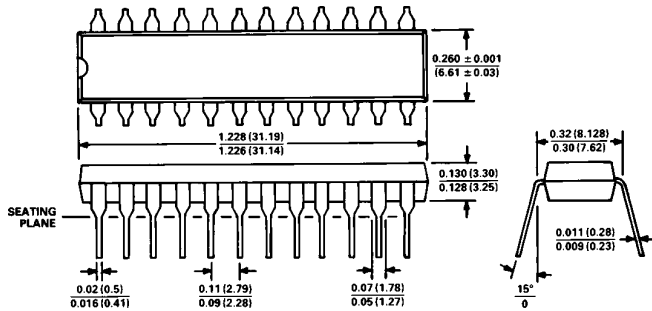


Figure 11. AD7538 Interface Circuit Using Latches to Minimize Digital Feedthrough

OUTLINE DIMENSIONS

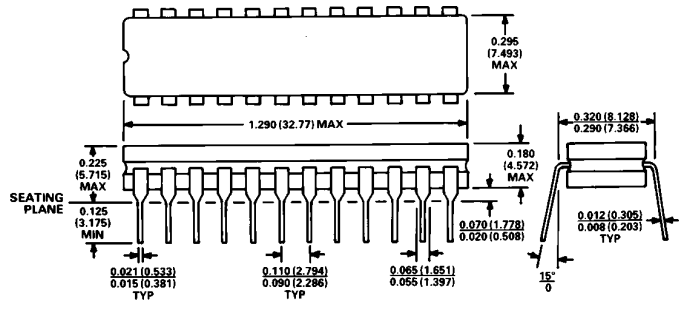
Dimensions shown in inches and (mm).

24-Pin Plastic Suffix (N)



- NOTES
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 2. PLASTIC LEADS WILL BE EITHER SOLDER DIPPED OR TIN LEAD PLATED IN ACCORDANCE WITH MIL-M-38510 REQUIREMENTS.

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